

Search Notes

Application/Control No.

10/069,750

Examiner

George R. Evanisko

Applicant(s)/Patent under
Reexamination

YOON ET AL.

Art Unit

3762

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-----------|-----------|----------|
| 600 | 16,17 | | |
| 623 | 3.1,3.11, | | |
| 623 | 3.13,3.14 | | |
| 623 | 3.16,3.17 | | |
| 623 | 3.18,3.19 | 7/21/2005 | ✓ |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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